High-Q/V Monolithic Diamond Microdisks Fabricated with Quasi-isotropic Etching

Behzad Khanaliloo,†‡ Matthew Mitchell,†‡ Aaron C. Hryciw,‡§ and Paul E. Barclay†‡

†Department of Physics and Astronomy and Institute for Quantum Science and Technology, University of Calgary, Calgary, AB T2N 1N4, Canada
‡National Institute for Nanotechnology, 11421 Saskatchewan Drive Northwest, Edmonton, AB T6G 2M9, Canada
§nanoFAB Facility, University of Alberta, Edmonton, AB T6G 2R3, Canada

ABSTRACT: Optical microcavities enhance light–matter interactions and are essential for many experiments in solid state quantum optics, optomechanics, and nonlinear optics. Single crystal diamond microcavities are particularly sought after for applications involving quantum emitters such as nitrogen vacancy centers, and for experiments that benefit from diamond’s excellent optical and mechanical properties. Light–matter coupling rates in experiments involving microcavities typically scale with $Q/V$, where $Q$ and $V$ are the microcavity quality-factor and mode-volume, respectively. Here we demonstrate that microdisk whispering gallery mode cavities with high $Q/V$ can be fabricated directly from bulk single crystal diamond. By using a quasi-isotropic oxygen plasma to etch along diamond crystal planes and undercut passivated diamond structures, we create monolithic diamond microdisks. Fiber taper based measurements show that these devices support TE- and TM-like optical modes with $Q > 1.1 \times 10^5$ and $V < 11(\lambda/n)^3$ at a wavelength of 1.5 $\mu$m.

KEYWORDS: Diamond, microcavity, nanophotonics, nanofabrication, microdisk

Single-crystal diamond is a desirable material for quantum and nonlinear nanophotonics applications owing to its large electronic bandgap and correspondingly broad optical transparency window, its relatively high refractive index, and its ability to host optically active color center spins. Diamond’s low multiphoton absorption and thermal stability amid high optical intensities can be harnessed for nonlinear effects including Raman lasing and parametric down-conversion. Diamond also possesses exceptional mechanical properties, such as a high Young’s modulus and low intrinsic mechanical dissipation, which in combination with its ability to support high optical field intensities, make diamond a promising platform for cavity-optomechanics experiments. The excellent coherence properties of electronic and nuclear spins associated with diamond color centers have enabled a wide range of quantum optics and quantum information processing applications including storing and manipulating quantum information, generating single photons, and creating entanglement. High quality-factor ($Q$), small mode-volume ($V$) optical microcavities, which increase the rate of light–matter interactions via a local density of states $\propto Q/V$, enhance many physical processes underlying these applications. Microdisk-based microcavities have proven to be particularly effective, enabling experiments such as single-photon generation, strong coupling between photons and quantum emitters, and sideband resolved optomechanics. Here we demonstrate microdisks fabricated from single crystal diamond that support optical modes with $Q > 1.1 \times 10^5$ and $V < 11(\lambda/n)^3$, providing a promising platform for future diamond-based applications requiring high $Q/V$ optical resonances.

Fabrication of nanophotonic devices from single crystal diamond is challenging owing to the wavelength-scale vertical and in-plane refractive index contrast required for optical confinement. Microdisk fabrication typically involves patterning devices from thin films supported by a substrate that can be undercut, leaving a microdisk supported by a pedestal. These devices support whispering gallery modes confined to the outer perimeter of the microdisk by refractive index contrast in the radial and vertical directions. Fabricating devices with the necessary vertical confinement in single crystal diamond has relied on patterning thin single crystal diamond films created using wafer bonding or lift-off and on hybrid approaches. However, the ability to create microcavities directly from bulk-diamond chips is desirable. Successful bulk-diamond fabrication approaches demonstrated prior to this work include focused ion-beam milling and Faraday cage angled plasma etching.

The approach demonstrated here, outlined in Figure 1, panel a and inspired by the SCREAM technique for creating structures from single crystal silicon, defines monolithic microdisks such as those shown in Figure 1, panels b and c.
from bulk diamond. This scalable technique relies upon undercutting of diamond with inductively coupled plasma reactive-ion etching (ICPRIE) along diamond crystal planes using a zero bias oxygen plasma. This approach, which was also recently used to create diamond nanobeams, shares the low material damage characteristics of the Faraday cage ICPRIE process of Burek et al. while providing an undercut profile intrinsic to the device geometry and etching parameters. It is fully compatible with standard nanofabrication tools and does not require modification to the etching tool setup.

The high-Q/V single crystal diamond microdisks studied here were fabricated as follows. A (100)-oriented optical-grade single crystal diamond chip (3 mm × 3 mm × 0.3 mm) grown using chemical vapor deposition (Element Six) was mechanically polished (Delaware Diamond Knives), cleaned in boiling piranha (3:1 H2SO4:H2O2), and coated with a thin (~5 nm) Ti anticharging layer, and EBL resist (ZEP 520A). Microdisks are patterned in ZEP using EBL and developed in ZED–N50. Patterns are transferred to the Si3N4 hard mask using an ICPRIE etch. ZEP is removed using a deep-UV exposure and Remover PG. Patterns are transferred to the diamond using an anisotropic O2 plasma ICPRIE etch. The diamond sidewalls are protected with a conformal coating of PECVD Si3N4. A short ICPRIE etch removes Si3N4 from the bottom of the etch windows. A zero bias O2 ICPRIE plasma undercuts the microdisks by etching along crystal planes. The sample is soaked in HF to remove the remaining Si3N4 layer, followed by a piranha clean.

Figure 1. (a) Schematic of the microdisk fabrication process steps. (i) Polished bulk single crystal diamond chips are cleaned in boiling piranha and coated with a 400 nm thick PECVD Si3N4 layer, coated with a thin (~5 nm) Ti anticharging layer, and EBL resist (ZEP 520A). (ii) Microdisks are patterned in ZEP using EBL and developed in ZED–N50. (iii) Patterns are transferred to the Si3N4 hard mask using an ICPRIE etch. ZEP is removed using a deep-UV exposure and Remover PG. (iv) Patterns are transferred to the diamond using an anisotropic O2 plasma ICPRIE etch. The diamond sidewalls are protected with a conformal coating of PECVD Si3N4. (v) A short ICPRIE etch removes Si3N4 from the bottom of the etch windows. (vi) A zero bias O2 ICPRIE plasma undercuts the microdisks by etching along crystal planes. (vii) The sample is soaked in HF to remove the remaining Si3N4 layer, followed by a piranha clean. (b) A 45° rotated scanning electron microscope (SEM) image of a 7.9 µm diameter microdisk in a diamond chip with (100)-oriented surface and edge crystal planes. (c) Overview of an array of fabricated microdisks.
Figure 2. (a) Illustration of the observed undercut etching processes. Etching along the \{100\} and \{111\} families of crystal planes is shown by black and red arrows, respectively. The left (right) image shows a right angle (45° rotated) view of the microdisk cross-section. (b) Tilted (60°) SEM image shows the (010) and \{111\} planes, marked in black and red, respectively. The \{111\} planes have an angle of $\theta = 35.26^\circ$ with respect to the diamond surface. (c) Top-down SEM image of the microdisk and windows showing the amount of undercut along the crystal directions. (d) SEM image illustrating how the octagon-shaped pedestal results from etching along \{100\} and \{111\} crystal planes. (e) A 60° tilted image of a broken and flipped microdisk.

Figure 2, panel a, and visible in the SEM images of fabricated devices in Figure 1, panels b and c, the quasi-isotropic undercut was observed to etch in directions defined by clearly visible diamond crystal planes. This behavior is consistent with the etch being dominantly chemical in nature and is commonly observed in wet etching of crystalline materials such as silicon. Figure 1, panel b identifies the \{100\} and \{111\} families of crystal planes along which the undercut of the unpatterned region surrounding the microdisk is observed to proceed. Etching along the \{100\} planes is horizontal or vertical, while etching along the \{111\} planes is at a 35.26° angle with respect to the diamond surface. The microdisk pillar is etched along similar families of crystal planes, which intersect as the pillar diameter is reduced. As indicated in Figure 2, panel d, purely vertical and horizontal etching along the \{100\} planes will result in a square microdisk pedestal and reduced microdisk thickness, respectively. Etching along the \{111\} planes defines surfaces at a 35.26° angle with respect to the sample surface. The resulting quasi-isotropic undercut etch creates an hourglass-shaped pedestal supporting a microdisk. The microdisk thickness was observed to vary by ±10%, measured from SEM images, where the thickest (thinnest) parts are aligned with the \{111\} (\{100\}) families of crystal planes (Figure 2e).

Figure 3, panel a shows the effect of microdisk diameter on the observed upward, minor inward, and major inward undercut etch distances, as defined in the Figure 3, panel a inset, for two sets of microdisks with different anisotropic and quasi-isotropic etch times. Etch distances were measured directly from SEM images. A small variation (<100 nm) in microdisk thickness was observed as a function of increasing microdisk diameter, resulting from smaller diamond microdisks requiring less undercut time before etching along the \{100\} and \{111\} families of crystal planes intersect. We have not observed any variation in etch properties across the chip area. In some cases, the microdisk pedestals are slightly misaligned with the microdisk center. Devices exhibiting this feature typically have windows that were not completely cleared during the anisotropic etching step, which in turn locally affects the undercut etch step.

The nonlinear nature of the undercut etch rates is shown in Figure 3, panel b, which gives etch distance as a function of etch time. The upward etch rate, which together with the initial anisotropic etch depth defines the microdisk thickness, is observed to vary quadratically with the undercut etch time. The minor inward etch distance, which defines the pedestal base size, has a similar etch time dependence. This is consistent with the minor inward etch distance and thickness being defined by the \((100), (100), (010), (010)\), and \((001)\) planes, respectively. The major inward etch distance increases approximately twice as fast as the upward and minor inward etch rates, which can be explained by the fact that the pedestal waist is etched simultaneously along both the \{100\} and \{111\} families of crystal planes. It is expected that the inward etch rates can be increased by introducing a second diamond
anisotropic etch step after step vi in Figure 1, panel a, as in the SCREAM process.35 Microdisk optical cavities require small pedestal size and wavelength scale thickness to support high-Q optical modes. Here, microdisk cavities were fabricated using a 35 min (∼2 μm deep) anisotropic etch followed by a 11 h quasi-isotropic etch to undercut the devices. The optical properties of the microdisks were measured by monitoring the wavelength-dependent transmission of a tunable diode laser (Santec TSL-510, wavelength range of 1500−1630 nm) through a dimpled optical fiber taper37 evanescently coupled to the microdisk. A typical normalized transmission spectra for a ∼7.0 μm diameter microdisk with a thickness of ∼1.0 μm and pillar base diameter of ∼4.6 μm is shown in Figure 4, panel a. This spectra contains many resonances corresponding to high-Q whispering-gallery modes of the microdisk, including high-Q TE- and TM-like modes, and modes that are higher-order in the radial and vertical directions. The highest-Q resonance observed in this microdisk is shown in Figure 4, panel b, and has loaded \( Q_t \approx 1.09 \times 10^5 \) and intrinsic \( Q_i \approx 1.15 \times 10^5 \), where \( 1/Q_c = 1/Q_t + 1/Q_i \), and \( Q_c \) accounts for the loading by the fiber taper coupling.38 This is comparable to the highest reported \( Q \) measured in single crystal microcavities to date.3,34 By using this technique, smaller microdisks optimized to support modes in the ∼637 nm wavelength range resonant with diamond nitrogen vacancy color centers can be fabricated. These devices will require shorter anisotropic (∼10 min) and isotropic (∼6 h) etch times and fabrication of smaller diameter dimpled optical fiber tapers.25,34

By comparing measured \( Q_i \) and mode wavelength spacing values with the mode spectrum predicted from finite-difference-time-domain (FDTD) simulations39 and measuring the polarization dependence of the resonance contrast, this resonance is identified as the fundamental TM-like mode. The predicted modal indices are \( [m,n,q] = [28,1,1] \), which describe the mode’s azimuthal \( (m) \), radial \( (n) \), and vertical \( (q) \) order. The resonance corresponding to the fundamental TE-like mode is shown in Figure 4, panel c, with \( Q_t \approx 1.02 \times 10^5 \) and modal indices of \([27,1,1]\). The doublet structure of the resonances in Figure 4, panels b and c is the result of backscattering and indicates that the resonances correspond to standing wave modes.40

Figure 3. (a) Undercut etch distance as a function of microdisk diameter. The upward, major inward, and minor inward etch distances, as defined in the inset, are shown for chip 1 (2) with ∼24 (15) minutes of anisotropic and ∼10 (7) hours of isotropic etch times with solid (dashed) lines as a guide for eye. Inset: schematic showing definition of upward, major inward, and minor inward etch distances. (b) Etch distance as a function of undercut etch time for a 7 μm microdisk, extracted by comparing chips 1 and 2. Solid lines are \( r^2 \) (t: time) fits to the data.

Figure 4. (a) Normalized transmission spectra of an optical fiber taper evanescently coupled to a single crystal diamond microdisk with diameter ∼7.0 μm and thickness ∼1.0 μm. Fundamental TE-like and TM-like modes and the associated electric field profiles are highlighted. (b,c) Narrow-range wavelength scan of a high-Q TM-like (TE-like) mode with \([m,n,q] = [28,1,1],[27,1,1]\) mode indices, respectively. (d) Highest and second highest quality factors for different microdisk diameters are shown by blue dots and red crosses, respectively.
FDTD calculated field profiles of these modes are shown in Figure 4, panel a, and are found to have standing-wave mode volume $V_{\text{TM}} \approx 10.7 \left(\lambda/n_{\mu}\right)^3$ and $V_{\text{TE}} \approx 12.6 \left(\lambda/n_{\mu}\right)^3$, as defined by the maximum electric field strength. These mode volumes are approximately an order of magnitude smaller than those of comparable high-Q whispering gallery mode microcavities.\textsuperscript{34}

Insight into the mechanism limiting Q of these devices is provided by the FDTD simulations and the observed Q dependence on microdisk diameter. Simulations of the idealized microdisk geometry studied here, which assumes perfect azimuthal symmetry for the pedestal, predict $Q > 10^7$ for both the fundamental TE- and TM-like modes, indicating that radiation loss and leakage into the substrate via the pedestal does not limit the Q of these devices. However, the noncylindrical pedestal shape created by the undercut etch can significantly affect optical loss in the microdisk by breaking the azimuthal microdisk symmetry and creating scattering not accounted for in the FDTD simulations performed here. The microdisk studied in Figure 4, panel a is the smallest diameter device on the chip and supports modes with Q comparable to the highest observed among of the tested devices. As shown in Figure 4, panel d, Q was observed to decrease with increasing microdisk diameter. This behavior contradicts expectations that Q should increase in larger microdisks due to stronger optical confinement.\textsuperscript{30,44} However, this behavior is consistent with interactions between the whispering gallery modes and the noncylindrical pedestal limiting Q: as the microdisk diameter increases, the noncylindrical pedestal extends closer to the microdisk perimeter, and its influence on Q increases. Moreover, the similar quality factors of the TE-like and TM-like modes indicate that scattering loss from the top or side surface is not the dominant sources of loss.\textsuperscript{41–45} Loss from interaction with the pedestal can be reduced by increasing the relative undercut either through fabrication of smaller diameter microdisks or using a longer undercut etch. It is expected that the addition of the previously mentioned second anisotropic diamond etch will reduce this effect by increasing the horizontal undercut rate.\textsuperscript{35} Finally, surface roughness also affects Q of these devices and may be reduced through improved cleaning and use of reflow techniques.\textsuperscript{41}

To maximize the enhancement provided by these devices for nonlinear, quantum, and optomechanical effects, further optimization of the fabrication process is possible. It is expected that increases to $Q/V$ are attainable by reducing the pedestal diameter and investigation of diamond cleaning and annealing recipes that may allow improvements in surface quality of the devices.\textsuperscript{31,44} Smaller pedestals are also desirable for reducing the dissipation of microdisk mechanical resonances used in optomechanics experiments.\textsuperscript{45,46} Although this fabrication process has been shown to allow creation of high mechanical quality factor nanobeams,\textsuperscript{36} it is expected that the relatively large pedestal diameter will limit the mechanical dissipation properties of the microdisk mechanical resonances.\textsuperscript{47} Reducing the relative pedestal size to minimize mechanical dissipation\textsuperscript{30} can be achieved through longer undercut etch times or by studying smaller microdisks operating at shorter wavelengths. Additional anisotropic etch steps may provide additional means for tailoring the pedestal profile.

Reduction of the microdisk diameter and thickness, and as a result $V_{\mu}$, is desirable to enhance processes involving light-matter coupling and is possible without reducing Q for sufficiently small pedestals. Given the high $Q/V$ of the devices measured here, it is expected that they will enable future experiments in high-frequency cavity optomechanics,\textsuperscript{25} and with further optimization to minimize $V$ while operating at visible wavelengths, will allow enhanced optical coupling to diamond color centers.\textsuperscript{30,31}

\section*{Author Information}

**Corresponding Author**

E-mail: pbardch@ualberta.ca.

**Notes**

The authors declare no competing financial interest.

**Acknowledgments**

This work was supported by NRC, CFI, iCORE/AITF, and NSERC.

**References**

(1) Aharonovich, I.; Greenstreet, A. D.; Prawer, S. Nat. Photonics 2011, 5, 397−405.
(3) Haussmann, B. J.; Bulu, I.; Venkataraman, V.; Deotare, P.; Lončar, M. Nat. Photonics 2014, 8, 369−374.
(18) Faraon, A.; Barclay, P. E.; Santori, C.; Fu, K.-M. C.; Beausoleil, R. G. Nat. Photonics 2011, 5, 301.